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APPLICANT: Niarfeix et al.

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GROUP: 3682

U.S. PATENT DOCUMENTS

EXAM. INITIALS	REF. DES.	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	U1	6338576	01/15/2002	Girardin et al. (translation of EP1037051)			
	U2	20040154895	08/12/2004	Thomire et al. (translation of WO 02052163)			
	U3	6109624	08/29/2000	Message et al.			
	U4	20040141669	07/22/2004	Landrieve et al.			

FOREIGN PATENT DOCUMENTS

EXAM. INITIALS	REF. DES.	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB CLASS	TRANSLATION YES/NO
	F1	0553716	08/04/1993	EP			
	F2	9418459	02/02/1995	DE			
	F3	0520853	12/30/1992	EP			abstract
	F4	0520853	12/30/1992	EP			
	F5	03065051	08/07/2003	WO			abstract
	F6	1037051	09/20/2000	EP			abstract
	F7	1037051	09/20/2000	EP			
	F8	2813644	03/08/2003	FR			abstract

OTHER ART

EXAM. INITIALS	REF. DES.	OTHER ART (including Author, Title, Date, Pertinent Pages, etc.)
	O1	International Search Report for PCT/FR 03/00264 mailed on May 28, 2003 (2 pages).

EXAMINER:

DATE CONSIDERED:

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to the patent owner.